Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/721,389	HATANAKA ET AL.		
Examiner	Art Unit		
Duy M. Dang	2624		

Duy M. Dang

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SEARCHED				
Class	Subclass	Date	Examiner	
382	232-239 244 246	5/30/2007	DD	
348	397.1			
	407.1			
	620			
375	240			
	240.1			
358	1.15			
updated	above ·	11/12/2007	DD	
				
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East (uspto, derwent, jpo, epo), see printouts	5/30/07 45 6/6/07	ans
Inventor search (east) see printouts		
Updated east text search	11/12/2007	DD
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